

Search Notes

Application/Control No.

10/814,369

Examiner

/Yonel Beaulieu/

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	1	4/10/2008	YB
	3		
	13-18		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Int. Search		4/10/2008	YB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	4/8/2008	YB
Int./Fwd+Bwd	4/10/2008	YB